

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10676820	STEINBERG ET AL.
<b>Examiner</b>	<b>Art Unit</b>	
Lee, John W	2624	

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
348	14.12	09/26/2007	John W. Lee
382	275	09/26/2007	John W. Lee

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Inventor Search	09/26/2007	John W. Lee
EAST Search	09/26/2007	John W. Lee
EAST Search	12/16/2008	John W. Lee

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

/JOHN W LEE/  
Examiner.Alt Unit 2624